

2454-7

**Joint ICTP-IAEA Workshop on Advanced Synchrotron Radiation Based X-ray
Spectrometry Techniques**

22 - 26 April 2013

Round Table Discussion

B. Beckhoff
*PTB, Berlin
Germany*

round table discussion

“New perspectives for advanced training and research for the IAEA member states in accessing and utilizing the newly developed XRF beamline at Elettra Sincrotrone Trieste” at the joint ICTP-IAEA Workshop on Advanced Synchrotron Radiation Based X-ray Spectrometry Techniques

Panel contributors: B. Beckhoff (PTB), A. Karydas (IAEA), D. Eichert (ELETTRA), M. Kiskinova (ELETTRA), J. Niemela (ICTP), H. Hoorani (SESAME)

Topics: *advanced training needs of workshop participants (survey results)*
research interests of workshop participants (survey results)
support schemes for access to SR by workshop organisers
open discussion on training schemes and research implementation

Survey - intention



Evaluation of the 37 input request forms provided

to facilitate the round table discussion “*New perspectives for advanced training and research for the IAEA member states in accessing and utilizing the newly developed XRF beamline at Elettra Sincrotrone Trieste*” at the joint ICTP-IAEA Workshop on Advanced Synchrotron Radiation Based X-ray Spectrometry Techniques

Please fill out this form, checking all boxes appropriate for you and / or your group / institution and return it by Tuesday during lunch to PTB staff.

Name
Status	29 workshop participant 3 associate 5 lecturer 0 organiser

Survey - training needs I

<p>Training – how many people in your group / institution will need training prior to access to Elettra ?</p>	<p>21 1 to 2 13 3 to 4 other: 1x > 10</p>
<p>Training – which of the following training formats would you and /or your group / institution find appealing ?</p>	<p>6 distance learning / e-learning 18 workshop with tutorials 26 hands-on instrumentation training other:</p>

Survey - training needs II

<p>Training – which of the following topics do you think would be interesting for basic training ?</p>	<p>15 synchrotron radiation 21 X-ray Fluorescence Analysis (XRF) 18 sample preparation 19 methods of data evaluation</p> <p>other:</p>
<p>Training – which of the following topics do you think would be interesting for advanced training ?</p>	<p>17 beamline parameter optimization 7 vacuum / UHV instrumentation 13 grazing incidence XRF 18 X-ray Absorption Spectroscopy (XAFS) 24 XRF and / or XAFS quantification</p> <p>other:</p>

Survey - research interests

<p>Research – which of the following application areas are of interest to you and / or your group / institution ?</p>	<p>25 advanced materials and nanoscience 15 art and cultural heritage 15 earth and environment sciences 10 industrial quality and process control 10 life sciences and forensics other:</p>
<p>Research – which of the following analytical aspects are of interest to you and / or your group / institution ?</p>	<p>31 quantitative elemental composition 20 layer thickness determination 25 elemental mapping or depth profiling 14 chemical binding states (speciation) 15 surface contamination or interfaces other: statistical meth., validation theory, local structure, impact of photo-electrons, highly homogeneous reference samples</p>

Survey - research interests

Research – which of the following **x-ray analytical techniques** are of interest to you and / or your group / institution ?

28 X-ray Fluorescence Analysis (XRF)
22 X-ray Absorption Spectroscopy (XAFS)
19 grazing incidence XRF and / or XAFS
15 micro-beam XRF and / or XAFS
12 confocal XRF and / or XAFS

other: 2x X-ray microscopy,
1x X-ray microtomography,
2x inelastic x-ray scattering,
2x electron spectroscopy,
2x powder XRD